

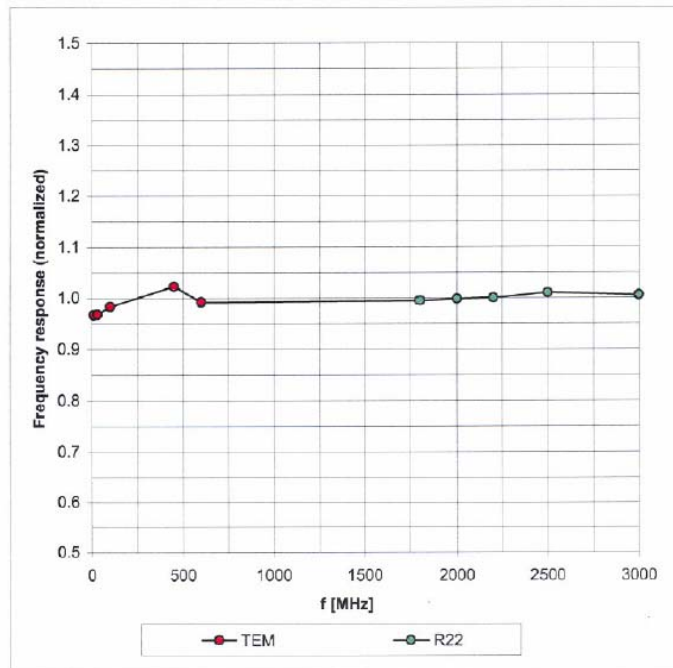


ET3DV6 SN:1788

September 30, 2004

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



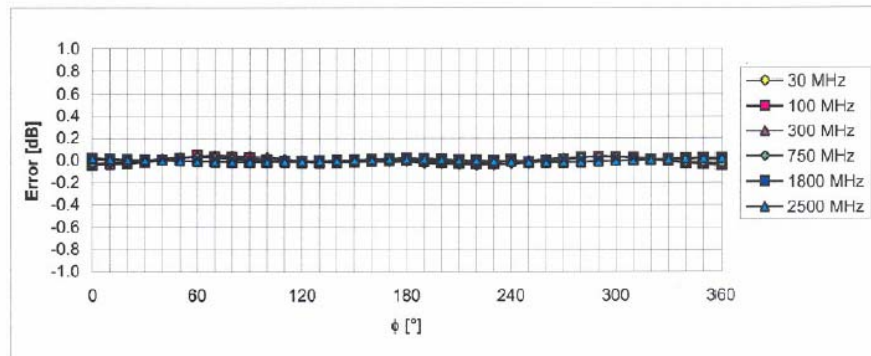
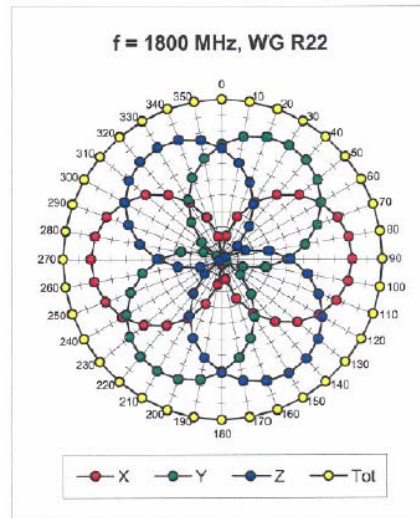
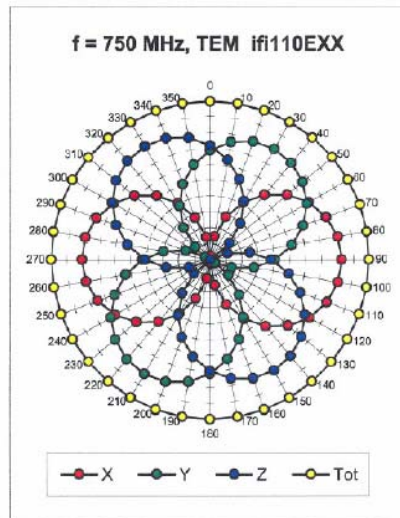
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)



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Receiving Pattern (ϕ), $\theta = 0^\circ$



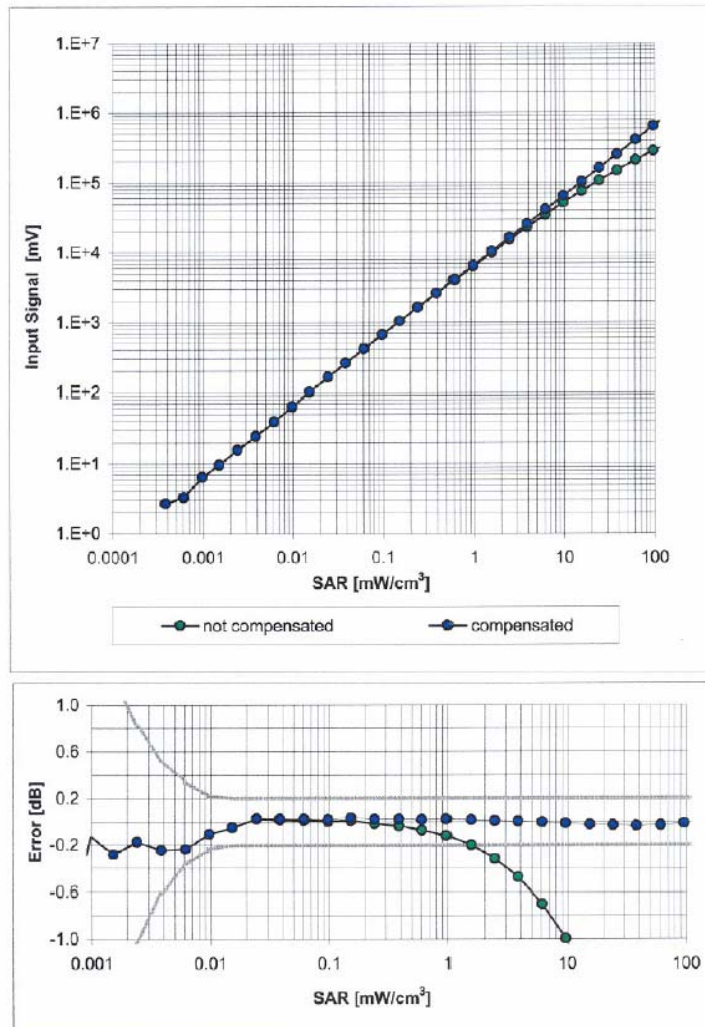
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)



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Dynamic Range $f(\text{SAR}_{\text{head}})$ (Waveguide R22, $f = 1800 \text{ MHz}$)



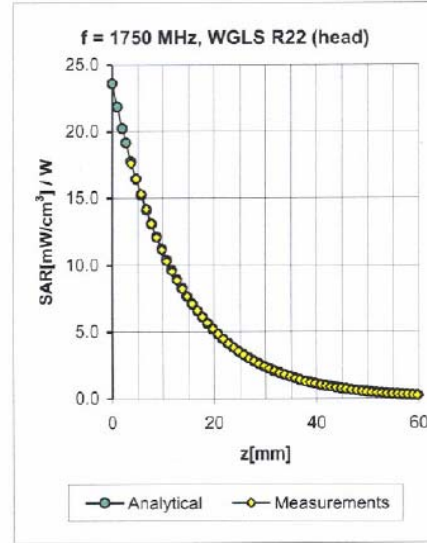
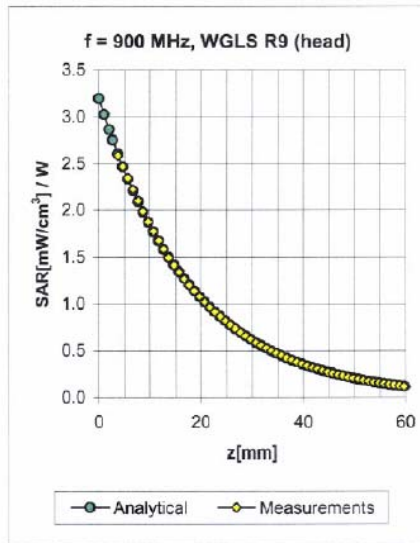
Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)



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Conversion Factor Assessment



f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	1.12	1.42	6.74 ± 11.0% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	1.07	1.44	6.63 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.56	2.31	5.37 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.55	2.42	5.16 ± 11.0% (k=2)
2000	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.54	2.59	4.88 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.65	2.22	4.56 ± 11.8% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	1.04	1.52	6.53 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.99	1.56	6.17 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.53	2.74	4.73 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.55	2.82	4.56 ± 11.0% (k=2)
2000	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.54	2.98	4.43 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.72	2.00	4.26 ± 11.8% (k=2)

^c The validity of ± 100 MHz only applies for DASY 4.3 B17 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

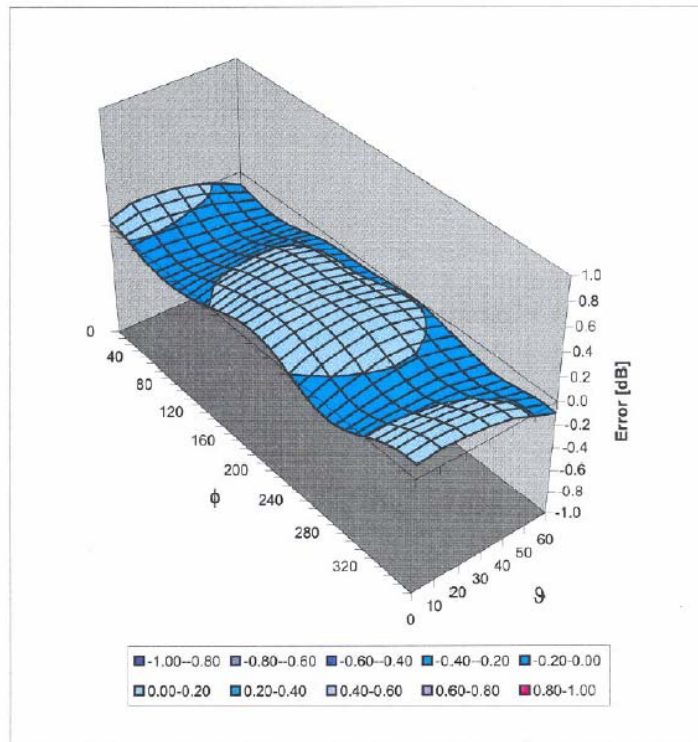


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Deviation from Isotropy in HSL

Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)



Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: DAE3-577_Nov04

CALIBRATION CERTIFICATE

Object: DAE3 - SD 000 D03 AA - SN: 577
Calibration procedure(s): QA CAL-06.v10
Calibration procedure for the data acquisition unit (DAE)
Calibration date: November 17, 2004
Condition of the calibrated item: In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Standards, ID #, Date/Check Date, and Scheduled Calibration/Check. Includes Fluke Process Calibrator Type 702 and Calibrator Box V1.1.

Calibrated by: Eric Hainfeld, Technician
Approved by: Fin Bornholt, R&D Director

Issued: November 17, 2004

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.



**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 108**

Glossary

DAE digital acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
- **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
- **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
- **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
- **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
- **Input resistance:** DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
- **Power consumption:** Typical value for information. Supply currents in various operating modes.



DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1µV, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.437 ± 0.1% (k=2)	403.891 ± 0.1% (k=2)	404.359 ± 0.1% (k=2)
Low Range	3.94121 ± 0.7% (k=2)	3.89867 ± 0.7% (k=2)	3.95408 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	127 ° ± 1 °
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Appendix

1. DC Voltage Linearity

High Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	200000	200000.6	0.00
Channel X + Input	20000	20001.77	0.01
Channel X - Input	20000	-19991.81	-0.04
Channel Y + Input	200000	199999.7	0.00
Channel Y + Input	20000	19999.20	0.00
Channel Y - Input	20000	-19994.82	-0.03
Channel Z + Input	200000	200000.2	0.00
Channel Z + Input	20000	19996.22	-0.02
Channel Z - Input	20000	-19996.74	-0.02

Low Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	200.05	0.03
Channel X - Input	200	-200.88	0.44
Channel Y + Input	2000	1999.9	0.00
Channel Y + Input	200	199.73	-0.13
Channel Y - Input	200	-200.53	0.27
Channel Z + Input	2000	2000.1	0.00
Channel Z + Input	200	199.25	-0.38
Channel Z - Input	200	-201.42	0.71

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	13.15	12.30
	-200	-12.61	-12.86
Channel Y	200	-7.43	-7.53
	-200	6.30	6.52
Channel Z	200	-0.16	0.31
	-200	-1.51	-1.48

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.90	-0.22
Channel Y	200	1.47	-	4.60
Channel Z	200	-1.40	-0.08	-



4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15948	15814
Channel Y	15960	16073
Channel Z	16236	16172

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	0.03	-3.07	1.24	0.58
Channel Y	-0.66	-2.19	1.96	0.55
Channel Z	-0.91	-2.82	0.42	0.39

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MΩ)	Measuring (MΩ)
Channel X	0.2000	199.3
Channel Y	0.2000	200.4
Channel Z	0.2001	199.5

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

10. Common Mode Bit Generation (verified during pre test)

Typical values	Bit set to High at Common Mode Error (V _{DC})
Channel X, Y, Z	+1.25